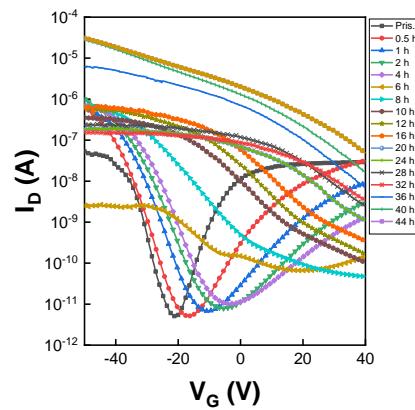
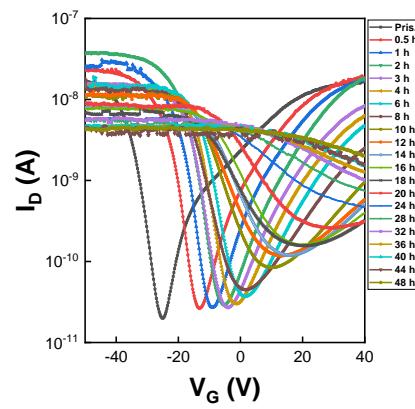


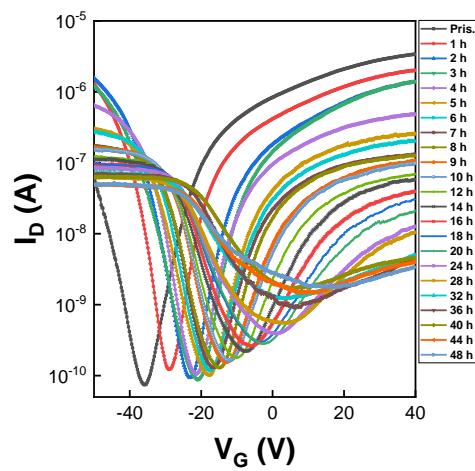
**Figure S1.** Transfer curves of MoTe<sub>2</sub> Device #1



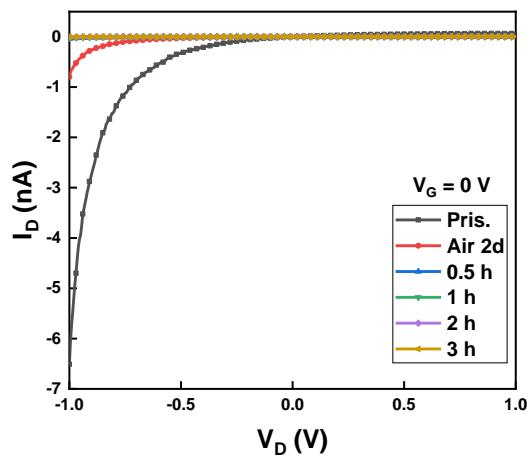
**Figure S2.** Transfer curves of MoTe<sub>2</sub> Device #2



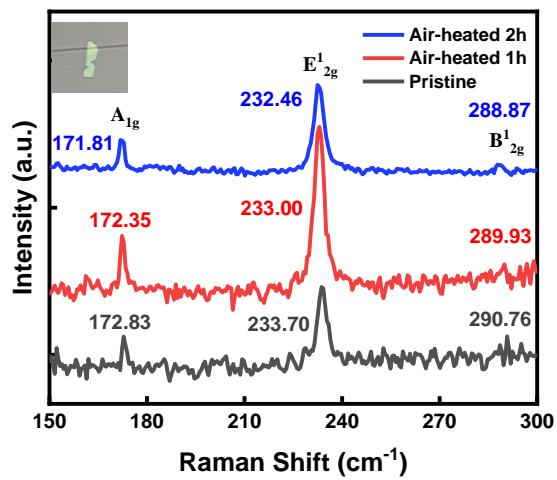
**Figure S3.** Transfer curves of MoTe<sub>2</sub> Device #3



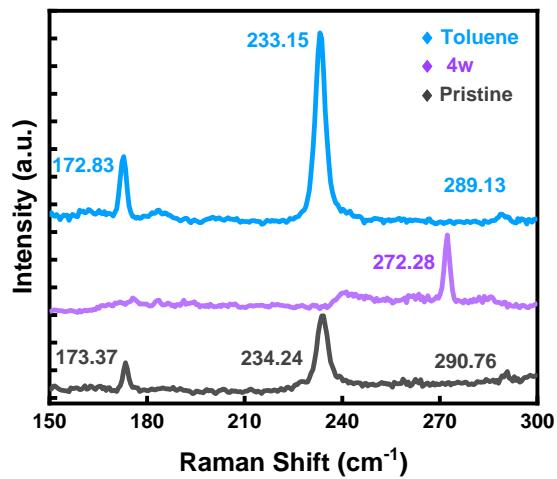
**Figure S4.** Transfer curves of MoTe<sub>2</sub> Device #4



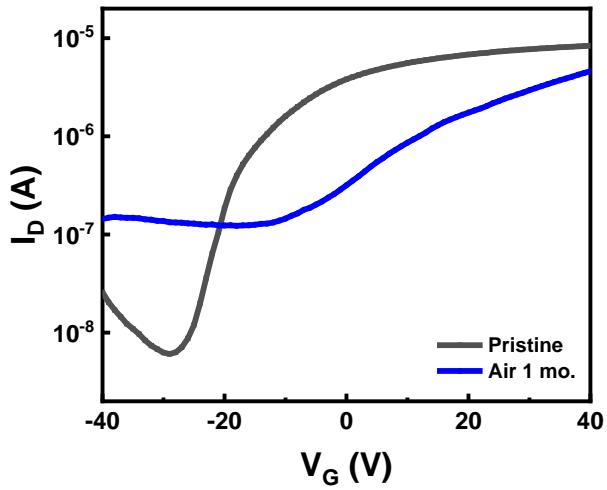
**Figure S5.** Output curves ( $I_{Ds}$ - $V_{Ds}$ ) of Device #1 under zero gate bias



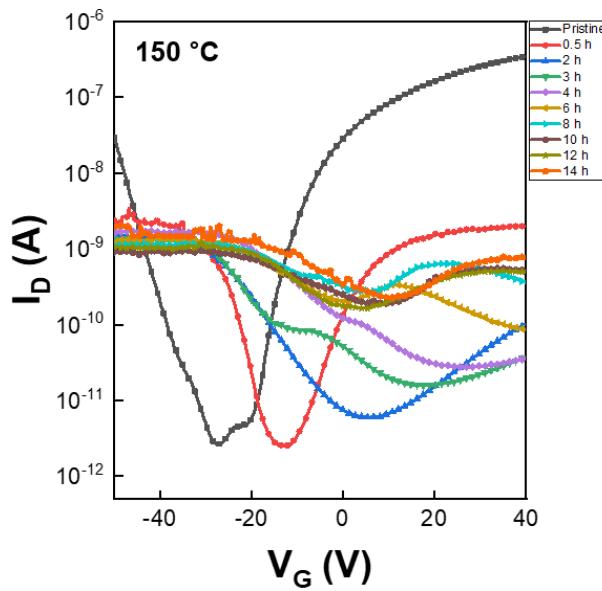
**Figure S6.** Raman spectra of air-heated MoTe<sub>2</sub> Device #2



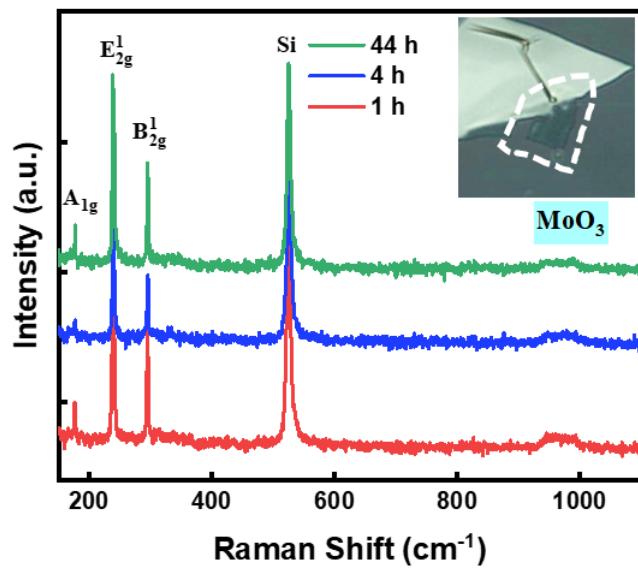
**Figure S7.** Raman spectra of toluene treated, air-exposed MoTe<sub>2</sub> flake



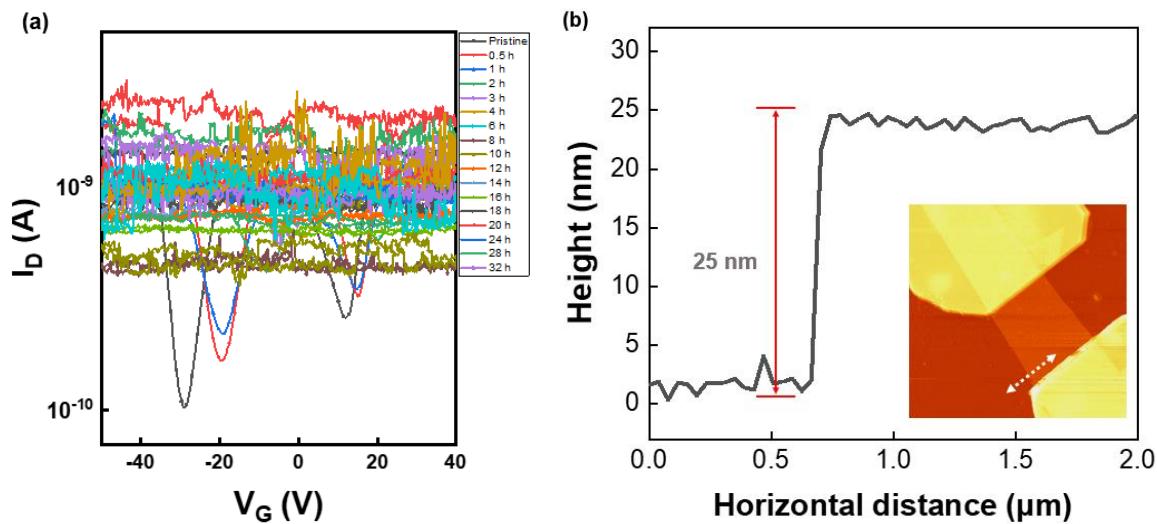
**Figure S8.** Transfer Characteristics curves of as-fabricated (dark grey) and air-exposed for 1-month (blue) MoTe<sub>2</sub> FET



**Figure S9.** Transfer Characteristics curves of MoTe<sub>2</sub> FET air heated at 150 °C



**Figure S10.** Raman Spectra of air heated MoTe<sub>2</sub> flake over a range 150 – 1100 cm<sup>-1</sup> (inset: optic image)



**Figure S11.** (a) Transfer curves and (b) AFM height profile (inset: AFM image) of MoTe<sub>2</sub> FET #5